

IN THE CLAIMS

Please add the following new claims:

Sub C1 61. A non-volatile memory circuit, comprising:
 a plurality of memory cells each comprising a ferroelectric capacitor connected in series with an access transistor between a plurality of respective drive lines and a common bit line,
 5 a plurality of word lines connected respectively to control terminals for a plurality of said access transistors for activating respective ones of said access transistors upon receipt of a selection signal for one of said memory cells, and
 a differential sense amplifier for reading from and writing
 10 to said memory cells, said sense amplifier having a first input connected to said bit line, and a second input connected to receive a reference signal, said sense amplifier having a data input/output terminal, said sense amplifier for differentially
B 3 driving said first and second input lines for reading a data
 15 state from one of said memory cells connected thereto and for applying the data state thus read to said input/output terminal, and said sense amplifier for driving said bit lines connected to said selected memory cell to one of a set of predetermined
 voltage states corresponding to a data state received at said
 20 input/output terminal for writing said received data state into the selected one of said memory cells.

62. A non-volatile memory circuit as recited in claim 61 wherein said reference signal is a predetermined voltage.

Sub C2 63. A non-volatile memory circuit as recited in claim 61 including a respective complementary memory cell for each of said plurality of memory cells wherein the output of the corresponding complementary memory cell is transmitted through a bit line to
 5 provide said reference signal to said sense amplifier.

64. A non-volatile memory circuit as recited in claim 61 including multiple sets of said memory cells, each set having a respective common bit line thereby forming a memory circuit matrix comprising rows and columns of said memory cells.

65. A non-volatile memory circuit as recited in claim 61 including means for isolating said sense amplifier from said bit line.

66. A non-volatile memory cell as recited in claim 61 including a dummy ferroelectric capacitor memory cell for said plurality of memory cells and a bit line connected to provide the output of the dummy memory cell as the reference signal to said sense amplifier.

~~67~~67. A non-volatile memory circuit, comprising:

a plurality of memory cells each comprising a ferroelectric capacitor connected in series with an access transistor between a plurality of respective bit lines and a common drive line,

a word line connected to control terminals of said access transistors for activating said transistors upon receipt of a selection signal for one of said memory cells, and

a plurality of differential sense amplifiers corresponding respectively to said bit lines for reading from and writing to said memory cells, each sense amplifiers having a first input connected to the corresponding bit line and a second input connected to receive a reference signal, each said sense amplifier having a data input/output terminal, said sense amplifiers for differentially driving said first and second inputs thereof for reading a data state from the one of said memory cells connected thereto, and for applying the data state then read to said input/output terminal, and said sense amplifiers for driving the corresponding bit lines connected to said memory cells to predetermined voltage states corresponding to a data state received at said input/output terminal for writing said received data state into the corresponding one of said memory cells.

~~68~~68. A non-volatile memory circuit as recited in claim 67 wherein said reference signal is a predetermined voltage.

~~69~~69. A non-volatile memory circuit as recited in claim 67 including a respective complementary memory cell for each of said plurality of memory cells wherein the output of the corresponding complementary memory cell for each of said plurality of memory cells wherein the output of the corresponding complementary memory cell is transferred through a bit line to provide said reference signal to the second input of the corresponding sense amplifier.